

<b>Notice of References Cited</b>	Application/Control No. 09/845,284	Applicant(s)/Patent Under Reexamination MOCHIZUKI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0079583	05-2003	FUNAKOSHI et al.	83/13
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 993038	04-2000	European	Watanabe et al	
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**NON-PATENT DOCUMENTS**

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